Reference Material Certificate

434/03

Aluminium Base (Type of Standard)
AlSi, Set 430

Certified Values

Element	Mass content [%]	Uncertainty [%]
Silicon (Si)	12.9	± 0.3
Iron (Fe)	0.33	± 0.01
Copper (Cu)	1.74	± 0.06
Manganese (Mn)	0.20	± 0.01
Magnesium (Mg)	1.45	± 0.05
Chromium (Cr)	0.103	± 0.005
Nickel (Ni)	1.49	± 0.04
Zinc (Zn)	0.129	± 0.008
Titanium (Ti)	0.114	± 0.005
Calcium (Ca)	0.015	± 0.001
Sodium (Na)	0.0079	± 0.0004
Phosphorus (P)	(0.0012)	
Lead (Pb)	0.0074	± 0.0006
Tin (Sn)	0.0054	± 0.0005
Strontium (Sr)	0.027	± 0.001
Vanadium (V)	0.0143	± 0.0005
Zirconium (Zr)	0.0112	± 0.0006

The uncertainty reported is the result of standard deviation of all results multiplied with a factor of two and represents approximately the 95% confidence interval.

Values in brackets ( ) are not certified but given for information only.

Manufacturing
This standard is produced using melt spinning, chopping and mixing followed by hot pressing and extrusion.

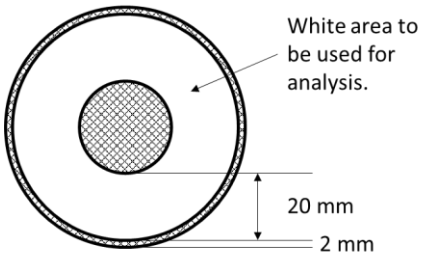
Homogeneity
Homogeneity testing is performed by means of spark emission spectroscopy. Tests involve making multiple measurements on individual samples taken at regular intervals along the entire length of each cast rod. Depending on the mass content of the element, the relative standard deviation of multiple measurements between discs or within one disc is typically found between 0.3% - 1% for alloying and other elements and 0.5% - 5% for trace elements.

Analysis
The values listed in this analysis certificate are the results of multiple analyses performed in our chemical analysis laboratory which is an accredited test facility for aluminium alloys according to the international standard ISO 17025. The analyses are based on established wet chemical procedures.

Description of Sample
This reference material is available in the form of discs (approx. Ø 60 x 25 mm).

Intended use and Stability
This certified reference material is primarily intended for use in spark optical emission spectroscopy. Other applications are X-ray fluorescence spectrometry (XRF) and classical wet chemical procedures. The minimum sample size for wet chemical analysis is 0.2g. The material will remain stable for the period given below (certification validity) if it is stored in a dry and clean environment at room temperature.

Instructions for Use
Calibration measurements should be made within a ring between 2mm and 22mm from the edge of the CRM face. For wet chemical analysis chips have to be prepared by turning or milling of the sample surface.



Traceability
Traceability of the certified mass contents to the SI (Système International d'Unités) is ensured by calibration using certified standard solutions or pure metals or substances of known stoichiometry.

Dr. Benedikt Moser
CTO

Patrik Bachmann
Head of Inorganic Analytics

Suisse Technology Partners Ltd.
Querstrasse 5
8212 Neuhausen am Rheinfall
Switzerland

Phone: +41 52 551 11 00
Fax : +41 52 551 11 99
Email: refmat@suisse-tp.ch
Internet: https://reference-materials.ch

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This certificate is valid until: May-2089